



# CERTIFICATE



This is to certify that

## Tera Probe, Inc.

Head Office, Development Center

KAKIYA Bldg., 2-7-17 Shin-Yokohama, Kohoku-ku, Yokohama-shi,  
Kanagawa-ken 222-0033 Japan

with the organizational units/sites as listed in the annex

has implemented and maintains a **Quality Management System.**

Scope:  
Management of Activity

Corporate Scope:  
Test service of semiconductor device

Through an audit, documented in a report, it was verified that the management system fulfills the requirements of the following standard:

## ISO 9001 : 2008

Certificate registration no.	497904 QM08
Date of original certification	2014-03-26
Date of revision	2014-05-28
Date of certification	2014-05-28
Valid until	2017-05-27



**UL DQS Inc.**

Ganesh Rao  
Managing Director

Accredited Body: UL DQS Inc., 1130 West Lake Cook Road, Suite 340, Buffalo Grove, IL 60089 USA  
Administrative Office: UL DQS Japan Inc., Shiba-Daimon Excellent Bldg 9F. 2-6-6 Shiba-Daimon, Minatoku,  
Tokyo 105-0012 Japan



**Annex to Certificate**  
**Registration No. 497904 QM08**

**Tera Probe, Inc.**

Head Office, Development Center

KAKIYA Bldg., 2-7-17 Shin-Yokohama, Kohoku-ku, Yokohama-shi,  
Kanagawa-ken 222-0033 Japan



**Location**

**Scope**

**497906**  
**Tera Probe, Inc.**  
**Kyushu Operation Center**  
**1580-1 Yunoura, Ashikita-machi,**  
**Ashikita-gun, Kumamoto-ken 869-5563**  
**Japan**

Test service of semiconductor device